

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/572,786	MILLER ET AL.	
	Examiner	Art Unit	Page 1 of 1
Alex W. Mok	2834		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0127920 A1	07-2003	Yamazaki et al.	310/58
*	B	US-5,907,203	05-1999	Chen et al.	310/65
*	C	US-6,020,662	02-2000	Chen et al.	310/65
*	D	US-5,095,235	03-1992	Kitamura, Yutaka	310/68D
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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